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#### What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

#### Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

#### Details

Product Status	Active
Core Processor	ARM® Cortex®-M3
Core Size	32-Bit Single-Core
Speed	120MHz
Connectivity	CANbus, Ethernet, I <sup>2</sup> C, IrDA, LINbus, Memory Card, SPI, UART/USART, USB OTG
Peripherals	Brown-out Detect/Reset, DMA, I <sup>2</sup> S, LCD, POR, PWM, WDT
Number of I/O	140
Program Memory Size	768KB (768K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	132K x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 3.6V
Data Converters	A/D 24x12b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	201-UFBGA
Supplier Device Package	176+25UFBGA (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/stm32f207ifh6

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

## 1 Introduction

This datasheet provides the description of the STM32F205xx and STM32F207xx lines of microcontrollers. For more details on the whole STMicroelectronics STM32 family, please refer to Section 2.1: Full compatibility throughout the family.

The STM32F205xx and STM32F207xx datasheet should be read in conjunction with the STM32F20x/STM32F21x reference manual. They will be referred to as STM32F20x devices throughout the document.

For information on programming, erasing and protection of the internal Flash memory, please refer to the STM32F20x/STM32F21x Flash programming manual (PM0059).

The reference and Flash programming manuals are both available from the STMicroelectronics website *www.st.com*.

For information on the Cortex<sup>®</sup>-M3 core please refer to the Cortex<sup>®</sup>-M3 Technical Reference Manual, available from the *www.arm.com* website.



## 2 Description

The STM32F20x family is based on the high-performance ARM<sup>®</sup> Cortex<sup>®</sup>-M3 32-bit RISC core operating at a frequency of up to 120 MHz. The family incorporates high-speed embedded memories (Flash memory up to 1 Mbyte, up to 128 Kbytes of system SRAM), up to 4 Kbytes of backup SRAM, and an extensive range of enhanced I/Os and peripherals connected to two APB buses, three AHB buses and a 32-bit multi-AHB bus matrix.

The devices also feature an adaptive real-time memory accelerator (ART Accelerator™) which allows to achieve a performance equivalent to 0 wait state program execution from Flash memory at a CPU frequency up to 120 MHz. This performance has been validated using the CoreMark benchmark.

All devices offer three 12-bit ADCs, two DACs, a low-power RTC, twelve general-purpose 16-bit timers including two PWM timers for motor control, two general-purpose 32-bit timers. a true number random generator (RNG). They also feature standard and advanced communication interfaces. New advanced peripherals include an SDIO, an enhanced flexible static memory control (FSMC) interface (for devices offered in packages of 100 pins and more), and a camera interface for CMOS sensors. The devices also feature standard peripherals.

- Up to three I<sup>2</sup>Cs
- Three SPIs, two I<sup>2</sup>Ss. To achieve audio class accuracy, the I<sup>2</sup>S peripherals can be clocked via a dedicated internal audio PLL or via an external PLL to allow synchronization.
- 4 USARTs and 2 UARTs
- A USB OTG high-speed with full-speed capability (with the ULPI)
- A second USB OTG (full-speed)
- Two CANs
- An SDIO interface
- Ethernet and camera interface available on STM32F207xx devices only.

Note: The STM32F205xx and STM32F207xx devices operate in the -40 to +105 °C temperature range from a 1.8 V to 3.6 V power supply. On devices in WLCSP64+2 package, if IRROFF is set to  $V_{DD}$ , the supply voltage can drop to 1.7 V when the device operates in the 0 to 70 °C temperature range using an external power supply supervisor (see Section 3.16).

A comprehensive set of power-saving modes allow the design of low-power applications.

STM32F205xx and STM32F207xx devices are offered in various packages ranging from 64 pins to 176 pins. The set of included peripherals changes with the device chosen. These features make the STM32F205xx and STM32F207xx microcontroller family suitable for a wide range of applications:

- Motor drive and application control
- Medical equipment
- Industrial applications: PLC, inverters, circuit breakers
- Printers, and scanners
- Alarm systems, video intercom, and HVAC
- Home audio appliances

Figure 4 shows the general block diagram of the device family.



		Table	2. STM3	82F205	xx feat	ures a	nd perip	heral co	ounts	5					
	Peripherals		ST	/132F205R	Rx			STM32	F205V	x		S	TM32F2	05Zx	
Flash memory in	n Kbytes	128	256	512	768	1024	128	256	512	768	1024	256	512	768	1024
SRAM in Kbytes	System (SRAM1+SRAM2)	64 (48+16)	96 (80+16)		128 (112+16)		64 (48+16)	96 (80+16)		128 (112+1	6)	96 (80+16)		128 (112+16	3)
	Backup			4					4				4		
FSMC memory of	controller			No							Yes <sup>(1)</sup>				
Ethernet								No							
	General-purpose							10							
	Advanced-control		2												
Timers	Basic		2												
	IWDG		Yes												
	WWDG							Yes							
RTC		Yes													
Random numbei	r generator		Yes												
	SPI/(I <sup>2</sup> S)		3/(2) <sup>(2)</sup>												
	l <sup>2</sup> C	3													
Comm. interfaces	USART UART	4 2													
interfaces	USB OTG FS	Yes													
	USB OTG HS						Yes								
	CAN		2												
Camera interface	e	No													
GPIOs				51				8	32				114		
SDIO		Yes													
12-bit ADC		3													
Number of chan	16 16 24														
12-bit DAC Number of chanı	nels	Yes 2													
Maximum CPU f	frequency	120 MHz													
Operating voltag	e	1.8 V to 3.6 V <sup>(3)</sup>													

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## 2.1 Full compatibility throughout the family

The STM32F205xx and STM32F207xx constitute the STM32F20x family whose members are fully pin-to-pin, software and feature compatible, allowing the user to try different memory densities and peripherals for a greater degree of freedom during the development cycle.

The STM32F205xx and STM32F207xx devices maintain a close compatibility with the whole STM32F10xxx family. All functional pins are pin-to-pin compatible. The STM32F205xx and STM32F207xx, however, are not drop-in replacements for the STM32F10xxx devices: the two families do not have the same power scheme, and so their power pins are different. Nonetheless, transition from the STM32F10xxx to the STM32F20x family remains simple as only a few pins are impacted.

*Figure 1*, *Figure 2* and *Figure 3* provide compatible board designs between the STM32F20x and the STM32F10xxx family.

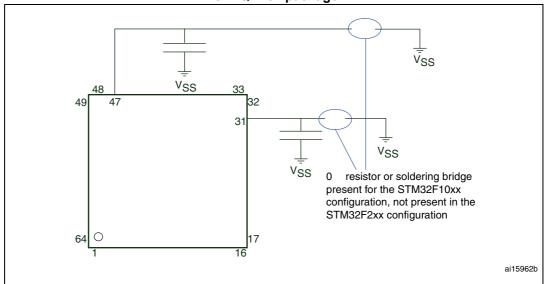
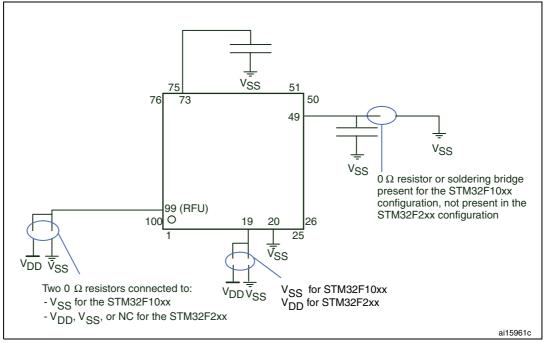


Figure 1. Compatible board design between STM32F10xx and STM32F2xx for LQFP64 package





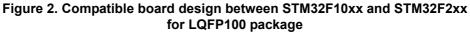
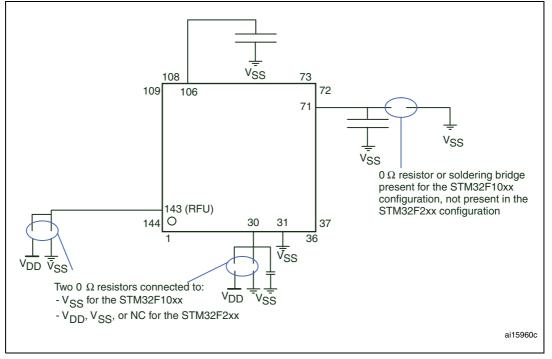


Figure 3. Compatible board design between STM32F10xx and STM32F2xx for LQFP144 package



1. RFU = reserved for future use.



The interface allows data transfer at up to 48 MHz in 8-bit mode, and is compliant with the SD Memory Card Specification Version 2.0.

The SDIO Card Specification Version 2.0 is also supported with two different databus modes: 1-bit (default) and 4-bit.

The current version supports only one SD/SDIO/MMC4.2 card at any one time and a stack of MMC4.1 or previous.

In addition to SD/SDIO/MMC, this interface is fully compliant with the CE-ATA digital protocol Rev1.1.

# 3.26 Ethernet MAC interface with dedicated DMA and IEEE 1588 support

Peripheral available only on the STM32F207xx devices.

The STM32F207xx devices provide an IEEE-802.3-2002-compliant media access controller (MAC) for ethernet LAN communications through an industry-standard mediumindependent interface (MII) or a reduced medium-independent interface (RMII). The STM32F207xx requires an external physical interface device (PHY) to connect to the physical LAN bus (twisted-pair, fiber, etc.). the PHY is connected to the STM32F207xx MII port using 17 signals for MII or 9 signals for RMII, and can be clocked using the 25 MHz (MII) or 50 MHz (RMII) output from the STM32F207xx.

The STM32F207xx includes the following features:

- Supports 10 and 100 Mbit/s rates
- Dedicated DMA controller allowing high-speed transfers between the dedicated SRAM and the descriptors (see the STM32F20x and STM32F21x reference manual for details)
- Tagged MAC frame support (VLAN support)
- Half-duplex (CSMA/CD) and full-duplex operation
- MAC control sublayer (control frames) support
- 32-bit CRC generation and removal
- Several address filtering modes for physical and multicast address (multicast and group addresses)
- 32-bit status code for each transmitted or received frame
- Internal FIFOs to buffer transmit and receive frames. The transmit FIFO and the receive FIFO are both 2 Kbytes, that is 4 Kbytes in total
- Supports hardware PTP (precision time protocol) in accordance with IEEE 1588 2008 (PTP V2) with the time stamp comparator connected to the TIM2 input
- Triggers interrupt when system time becomes greater than target time

### 3.27 Controller area network (CAN)

The two CANs are compliant with the 2.0A and B (active) specifications with a bitrate up to 1 Mbit/s. They can receive and transmit standard frames with 11-bit identifiers as well as extended frames with 29-bit identifiers. Each CAN has three transmit mailboxes, two receive FIFOS with 3 stages and 28 shared scalable filter banks (all of them can be used even if one



## 3.30 Audio PLL (PLLI2S)

The devices feature an additional dedicated PLL for audio I<sup>2</sup>S application. It allows to achieve error-free I<sup>2</sup>S sampling clock accuracy without compromising on the CPU performance, while using USB peripherals.

The PLLI2S configuration can be modified to manage an  $I^2S$  sample rate change without disabling the main PLL (PLL) used for CPU, USB and Ethernet interfaces.

The audio PLL can be programmed with very low error to obtain sampling rates ranging from 8 kHz to 192 kHz.

In addition to the audio PLL, a master clock input pin can be used to synchronize the I2S flow with an external PLL (or Codec output).

## 3.31 Digital camera interface (DCMI)

The camera interface is not available in STM32F205xx devices.

STM32F207xx products embed a camera interface that can connect with camera modules and CMOS sensors through an 8-bit to 14-bit parallel interface, to receive video data. The camera interface can sustain up to 27 Mbyte/s at 27 MHz or 48 Mbyte/s at 48 MHz. It features:

- Programmable polarity for the input pixel clock and synchronization signals
- Parallel data communication can be 8-, 10-, 12- or 14-bit
- Supports 8-bit progressive video monochrome or raw Bayer format, YCbCr 4:2:2 progressive video, RGB 565 progressive video or compressed data (like JPEG)
- Supports continuous mode or snapshot (a single frame) mode
- Capability to automatically crop the image

### 3.32 True random number generator (RNG)

All STM32F2xxx products embed a true RNG that delivers 32-bit random numbers produced by an integrated analog circuit.

## 3.33 GPIOs (general-purpose inputs/outputs)

Each of the GPIO pins can be configured by software as output (push-pull or open-drain, with or without pull-up or pull-down), as input (floating, with or without pull-up or pull-down) or as peripheral alternate function. Most of the GPIO pins are shared with digital or analog alternate functions. All GPIOs are high-current-capable and have speed selection to better manage internal noise, power consumption and electromagnetic emission.

The I/O alternate function configuration can be locked if needed by following a specific sequence in order to avoid spurious writing to the I/Os registers.

To provide fast I/O handling, the GPIOs are on the fast AHB1 bus with a clock up to 120 MHz that leads to a maximum I/O toggling speed of 60 MHz.



		Pi	ns								
LQFP64	WLCSP64+2	LQFP100	LQFP144	LQFP176	UFBGA176	Pin name (function after reset) <sup>(1)</sup>	Pin type	I/O structure	Note	Alternate functions	Additional functions
-	-	-	-	84	N12	PH7	I/O	FT	-	I2C3_SCL, ETH_MII_RXD3, EVENTOUT	-
-	-	-	-	85	M12	PH8	I/O	FT	-	I2C3_SDA, DCMI_HSYNC, EVENTOUT	-
-	-	-	-	86	M13	PH9	I/O	FT	-	I2C3_SMBA, TIM12_CH2, DCMI_D0, EVENTOUT	-
-	-	-	-	87	L13	PH10	I/O	FT	-	TIM5_CH1, DCMI_D1, EVENTOUT	-
-	-	-	-	88	L12	PH11	I/O	FT	-	TIM5_CH2, DCMI_D2, EVENTOUT	-
-	-	-	-	89	K12	PH12	I/O	FT	-	TIM5_CH3, DCMI_D3, EVENTOUT	-
-	-	-	-	90	H12	V <sub>SS</sub>	S	-	-	-	-
-	-	-	-	91	J12	V <sub>DD</sub>	S	-	-	-	-
33	J1	51	73	92	P12	PB12	I/O	FT	-	SPI2_NSS, I2S2_WS, I2C2_SMBA, USART3_CK, TIM1_BKIN, CAN2_RX, OTG_HS_ULPI_D5, ETH_RMII_TXD0, ETH_MII_TXD0, OTG_HS_ID, EVENTOUT	-
34	H2	52	74	93	P13	PB13	I/O	FT	-	SPI2_SCK, I2S2_SCK, USART3_CTS, TIM1_CH1N, CAN2_TX, OTG_HS_ULPI_D6, ETH_RMII_TXD1, ETH_MII_TXD1, EVENTOUT	OTG_HS_ VBUS
35	H1	53	75	94	R14	PB14	I/O	FT	-	SPI2_MISO, TIM1_CH2N, TIM12_CH1, OTG_HS_DM USART3_RTS, TIM8_CH2N, EVENTOUT	-
36	G1	54	76	95	R15	PB15	I/O	FT	-	SPI2_MOSI, I2S2_SD, TIM1_CH3N, TIM8_CH3N, TIM12_CH2, OTG_HS_DP, RTC_50Hz, EVENTOUT	-
-	-	55	77	96	P15	PD8	I/O	FT	-	FSMC_D13, USART3_TX, EVENTOUT	-

Table 8. STM32F20x pin and ball definitions (continued)



		Pi	ns								
LQFP64	WLCSP64+2	LQFP100	LQFP144	LQFP176	UFBGA176	Pin name (function after reset) <sup>(1)</sup>	Pin type	I/O structure	Note	Alternate functions	Additional functions
38	F2	64	97	116	G15	PC7	I/O	FT	-	I2S3_MCK, TIM8_CH2, SDIO_D7, USART6_RX, DCMI_D1, TIM3_CH2, EVENTOUT	-
39	F3	65	98	117	G14	PC8	I/O	FT	-	TIM8_CH3,SDIO_D0, TIM3_CH3, USART6_CK, DCMI_D2, EVENTOUT	-
40	D1	66	99	118	F14	PC9	I/O	FT	-	I2S2_CKIN, I2S3_CKIN, MCO2, TIM8_CH4, SDIO_D1, I2C3_SDA, DCMI_D3, TIM3_CH4, EVENTOUT	-
41	E2	67	100	119	F15	PA8	I/O	FT	-	MCO1, USART1_CK, TIM1_CH1, I2C3_SCL, OTG_FS_SOF, EVENTOUT	-
42	E3	68	101	120	E15	PA9	I/O	FT	-	USART1_TX, TIM1_CH2, I2C3_SMBA, DCMI_D0, EVENTOUT	OTG_FS_ VBUS
43	D3	69	102	121	D15	PA10	I/O	FT	-	USART1_RX, TIM1_CH3, OTG_FS_ID,DCMI_D1, EVENTOUT	-
44	D2	70	103	122	C15	PA11	I/O	FT	-	USART1_CTS, CAN1_RX, TIM1_CH4,OTG_FS_DM, EVENTOUT	-
45	C1	71	104	123	B15	PA12	I/O	FT	-	USART1_RTS, CAN1_TX, TIM1_ETR, OTG_FS_DP, EVENTOUT	-
46	B2	72	105	124	A15	PA13 (JTMS-SWDIO)	I/O	FT	-	JTMS-SWDIO, EVENTOUT	-
47	C2	73	106	125	F13	V <sub>CAP_2</sub>	S	-	-	-	-
-	B1	74	107	126	F12	V <sub>SS</sub>	S	-	-	-	-
48	A8	75	108	127	G13	V <sub>DD</sub>	S	-	I	-	
-	-	-	-	128	E12	PH13	I/O	FT	-	TIM8_CH1N, CAN1_TX, EVENTOUT	-
-	-	-	-	129	E13	PH14	I/O	FT	-	TIM8_CH2N, DCMI_D4, EVENTOUT	-

Table 8. STM32F20x pin and ball definitions	(continued)
	(



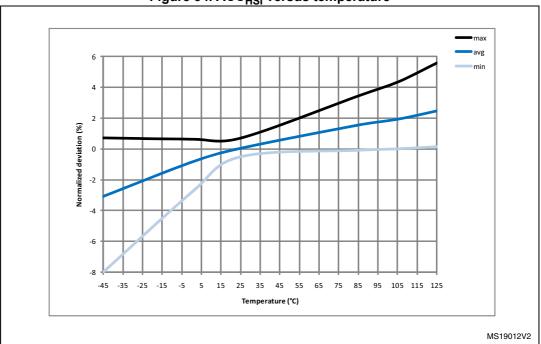


Figure 34. ACC<sub>HSI</sub> versus temperature

#### Low-speed internal (LSI) RC oscillator

Table 33. LS	l oscillator	characteristics <sup>(1)</sup>
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Symbol	Parameter	Min	Тур	Мах	Unit
f <sub>LSI</sub> <sup>(2)</sup>	Frequency	17	32	47	kHz
t <sub>su(LSI)</sub> <sup>(3)</sup>	LSI oscillator startup time	-	15	40	μs
I <sub>DD(LSI)</sub> <sup>(3)</sup>	LSI oscillator power consumption	-	0.4	0.6	μA

1.  $V_{DD}$  = 3 V,  $T_A$  = -40 to 105 °C unless otherwise specified.

2. Guaranteed by characterization results, not tested in production.

3. Guaranteed by design, not tested in production.



#### 6.3.11 PLL spread spectrum clock generation (SSCG) characteristics

The spread spectrum clock generation (SSCG) feature allows to reduce electromagnetic interferences (see *Table 42: EMI characteristics*). It is available only on the main PLL.

Symbol	Parameter	Min	Тур	Max <sup>(1)</sup>	Unit
f <sub>Mod</sub>	Modulation frequency	-	-	10	KHz
md	Peak modulation depth	0.25	-	2	%
MODEPER * INCSTEP	-	-	-	2 <sup>15</sup> –1	-

Table 36.	SSCG	parameters	constraint

1. Guaranteed by design, not tested in production.

#### Equation 1

The frequency modulation period (MODEPER) is given by the equation below:

```
MODEPER = round[f_{PLL \ IN}/ \ (4 \times f_{Mod})]
```

 $f_{\text{PLL}\ \text{IN}}$  and  $f_{\text{Mod}}$  must be expressed in Hz.

As an example:

If  $f_{PLL_IN} = 1$  MHz and  $f_{MOD} = 1$  kHz, the modulation depth (MODEPER) is given by equation 1:

MODEPER = round 
$$[10^{6}/(4 \times 10^{3})] = 250$$

#### **Equation 2**

Equation 2 allows to calculate the increment step (INCSTEP):

INCSTEP = round[
$$((2^{15} - 1) \times md \times PLLN)/(100 \times 5 \times MODEPER)$$
]

f<sub>VCO OUT</sub> must be expressed in MHz.

With a modulation depth (md) =  $\pm 2$  % (4 % peak to peak), and PLLN = 240 (in MHz):

INCSTEP = round[ $((2^{15}-1) \times 2 \times 240)/(100 \times 5 \times 250)$ ] = 126md(quantitazed)%

An amplitude quantization error may be generated because the linear modulation profile is obtained by taking the quantized values (rounded to the nearest integer) of MODPER and INCSTEP. As a result, the achieved modulation depth is quantized. The percentage quantized modulation depth is given by the following formula:

$$md_{quantized}$$
% = (MODEPER × INCSTEP × 100 × 5)/ ((2<sup>15</sup> - 1) × PLLN)

As a result:

$$md_{quantized} \% = (250 \times 126 \times 100 \times 5) / ((2^{15} - 1) \times 240) = 2.0002\%$$
(peak)



Symbol	Parameter	Conditions	Min	Тур	Max	Unit
		Write / Erase 8-bit mode V <sub>DD</sub> = 1.8 V	-	5	Max - -	
I <sub>DD</sub>	Supply current	Write / Erase 16-bit mode V <sub>DD</sub> = 2.1 V	-	8	-	mA
		Write / Erase 32-bit mode V <sub>DD</sub> = 3.3 V	-	12	Max - -	

Table 37. Flash memory characteristics

#### Table 38. Flash memory programming

Symbol	Parameter	Conditions	Min <sup>(1)</sup>	Тур	Max <sup>(1)</sup>	Unit
t <sub>prog</sub>	Word programming time	Program/erase parallelism (PSIZE) = x 8/16/32	-	16	100 <sup>(2)</sup>	μs
		Program/erase parallelism (PSIZE) = x 8	-	400	800	
t <sub>ERASE16KB</sub>	Sector (16 KB) erase time	Program/erase parallelism (PSIZE) = x 16	-	300	600	ms
		Program/erase parallelism (PSIZE) = x 32	-	250	100 <sup>(2)</sup> 800	
		Program/erase parallelism (PSIZE) = x 8	-	1200	2400	
t <sub>ERASE64KB</sub>	Sector (64 KB) erase time	Program/erase parallelism (PSIZE) = x 16	-	700	1400	ms
		Program/erase parallelism (PSIZE) = x 32	-	550	1100	
		Program/erase parallelism (PSIZE) = x 8	-	2	4	
t <sub>ERASE128KB</sub>	Sector (128 KB) erase time	Program/erase parallelism (PSIZE) = x 16	-	1.3	2.6	s
		Program/erase parallelism (PSIZE) = x 32	-	1	100 <sup>(2)</sup> 800         600         500         2400         1400         1100         4         2.6         2         32         22         16         3.6	
		Program/erase parallelism (PSIZE) = x 8	-	16	32	
t <sub>ME</sub>	Mass erase time	Program/erase parallelism (PSIZE) = x 16	-	11	22	s
		Program/erase parallelism (PSIZE) = x 32	-	8	16	
		32-bit program operation	2.7	-	3.6	V
V <sub>prog</sub>	Programming voltage	16-bit program operation	2.1	-	3.6	V
		8-bit program operation	1.8	-	3.6	V

1. Guaranteed by characterization results, not tested in production.

2. The maximum programming time is measured after 100K erase operations.



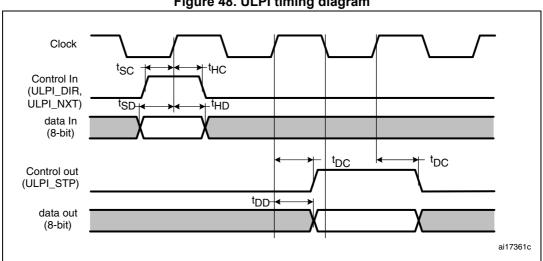


Figure 48. ULPI timing diagram

#### Table 61. ULPI timing

Symbol	Parameter	Valu	ue <sup>(1)</sup>	Unit
Symbol	Farameter	Min.	Max.	Unit
+	Control in (ULPI_DIR) setup time	-	2.0	
t <sub>SC</sub>	Control in (ULPI_NXT) setup time	-	1.5	
t <sub>HC</sub>	Control in (ULPI_DIR, ULPI_NXT) hold time	0	-	
t <sub>SD</sub>	Data in setup time	-	2.0	ns
t <sub>HD</sub>	Data in hold time	0	-	
t <sub>DC</sub>	Control out (ULPI_STP) setup time and hold time	-	9.2	
t <sub>DD</sub>	Data out available from clock rising edge	-	10.7	

1.  $V_{DD}$  = 2.7 V to 3.6 V and  $T_A$  = -40 to 85 °C.

#### **Ethernet characteristics**

Table 62 shows the Ethernet operating voltage.

#### Table 62. Ethernet DC electrical characteristics

Symbol		Parameter	Min. <sup>(1)</sup>	Max. <sup>(1)</sup>	Unit
Input level	$V_{DD}$	Ethernet operating voltage	2.7	3.6	V

1. All the voltages are measured from the local ground potential.

Table 63 gives the list of Ethernet MAC signals for the SMI (station management interface) and Figure 49 shows the corresponding timing diagram.



Symbol	Parameter	Min	Тур	Мах	Unit	Comments		
Update rate <sup>(2)</sup>	Max frequency for a correct DAC_OUT change when small variation in the input code (from code i to i+1LSB)	-	-	1	MS/s	$C_{LOAD} \le 50 \text{ pF},$ $R_{LOAD} \ge 5 \text{ k}\Omega$		
t <sub>WAKEUP</sub> <sup>(4)</sup>	Wakeup time from off state (Setting the ENx bit in the DAC Control register)	-	6.5	10	μs	$\label{eq:CLOAD} \begin{array}{l} C_{LOAD} \leq 50 \text{ pF}, \ R_{LOAD} \geq 5 \ k\Omega \\ \text{input code between lowest and highest} \\ \text{possible ones.} \end{array}$		
PSRR+ <sup>(2)</sup>	Power supply rejection ratio (to $V_{DDA}$ ) (static DC measurement)	-	-67	-40	dB	No R <sub>LOAD</sub> , C <sub>LOAD</sub> = 50 pF		

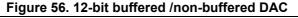
 Table 68. DAC characteristics (continued)

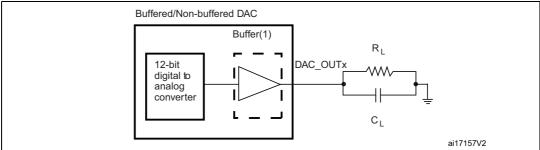
 On devices in WLCSP64+2 package, if IRROFF is set to V<sub>DD</sub>, the supply voltage can drop to 1.7 V when the device operates in the 0 to 70 °C temperature range using an external power supply supervisor (see <u>Section 3.16</u>).

2. Guaranteed by design, not tested in production.

3. The quiescent mode corresponds to a state where the DAC maintains a stable output level to ensure that no dynamic consumption occurs.

4. Guaranteed by characterization results, not tested in production.





1. The DAC integrates an output buffer that can be used to reduce the output impedance and to drive external loads directly, without the use of an external operational amplifier. The buffer can be bypassed by configuring the BOFFx bit in the DAC\_CR register.

#### 6.3.22 Temperature sensor characteristics

Table 69	. Temperature	sensor	characteristics
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Symbol	Parameter		Тур	Max	Unit
T <sub>L</sub> <sup>(1)</sup>	V <sub>SENSE</sub> linearity with temperature	-	±1	<u>+2</u>	°C
Avg_Slope <sup>(1)</sup>	Average slope	-	2.5	-	mV/°C
V <sub>25</sub> <sup>(1)</sup>	Voltage at 25 °C	-	0.76	-	V
t <sub>START</sub> <sup>(2)</sup>	Startup time	-	6	10	μs
T <sub>S_temp</sub> <sup>(2)</sup>	ADC sampling time when reading the temperature (1 °C accuracy)		-	-	μs

1. Guaranteed by characterization results, not tested in production.

2. Guaranteed by design, not tested in production.



Symbol	Parameter	Min	Мах	Unit
t <sub>w(NWE)</sub>	FSMC_NWE low width	4T <sub>HCLK</sub> - 1	4T <sub>HCLK</sub> + 3	ns
t <sub>v(NWE-D)</sub>	FSMC_NWE low to FSMC_D[15-0] valid	-	0	ns
t <sub>h(NWE-D)</sub>	FSMC_NWE high to FSMC_D[15-0] invalid	3T <sub>HCLK</sub>	-	ns
t <sub>d(D-NWE)</sub>	FSMC_D[15-0] valid before FSMC_NWE high	5T <sub>HCLK</sub>	-	ns
t <sub>d(ALE-NWE)</sub>	FSMC_ALE valid before FSMC_NWE low	-	3T <sub>HCLK</sub> + 2	ns
t <sub>h(NWE-ALE)</sub>	FSMC_NWE high to FSMC_ALE invalid	3T <sub>HCLK</sub> - 2	-	ns

 Table 83. Switching characteristics for NAND Flash write cycles<sup>(1)(2)</sup>

1. C<sub>L</sub> = 30 pF.

2. Guaranteed by characterization results, not tested in production.

#### 6.3.26 Camera interface (DCMI) timing specifications

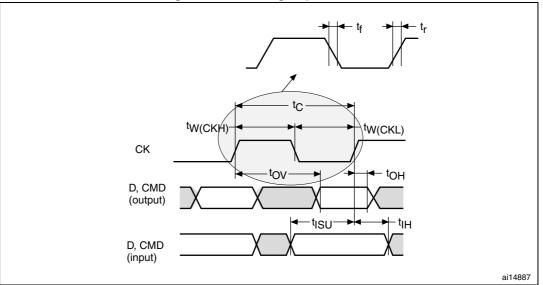
Symbol	Parameter	Conditions	Min	Мах
-	Frequency ratio DCMI_PIXCLK/f <sub>HCLK</sub>	DCMI_PIXCLK= 48 MHz	-	0.4

#### 6.3.27 SD/SDIO MMC card host interface (SDIO) characteristics

Unless otherwise specified, the parameters given in *Table 85* are derived from tests performed under ambient temperature,  $f_{PCLKx}$  frequency and  $V_{DD}$  supply voltage conditions summarized in *Table 14*.

Refer to Section 6.3.16: I/O port characteristics for more details on the input/output alternate function characteristics (D[7:0], CMD, CK).

Figure 75. SDIO high-speed mode





## 7.2 WLCSP64+2 package information

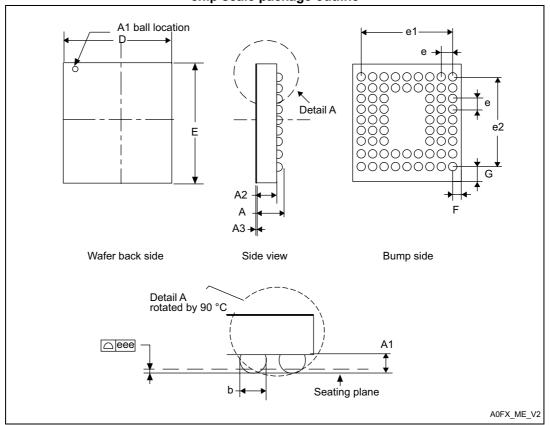


Figure 79. WLCSP64+2 - 66-ball, 3.639 x 3.971 mm, 0.4 mm pitch wafer level chip scale package outline

1. Drawing is not to scale.

Table 88. WLCSP64+2 - 66-ball, 4.539 x 4.911 mm, 0.4 mm pitch wafer level chip scale
package mechanical data

Symbol		millimeters		inches <sup>(1)</sup>			
Symbol	Min	Тур	Max	Min	Тур	Мах	
А	0.540	0.570	0.600	0.0213	0.0224	0.0236	
A1	-	0.190	-	-	0.0075	-	
A2	-	0.380	-	-	0.0150	-	
A3	-	0.025	-	-	0.010	-	
b <sup>(2)</sup>	0.240	0.270	0.300	0.0094	0.0106	0.0118	
D	3.604	3.939	3.674	0.1419	0.1551	0.1446	
E	3.936	3.971	4.006	0.1550	0.1563	0.1577	
е	-	0.400	-	-	0.0157	-	
e1	-	3.200	-	-	0.1260	-	
e2	-	3.200	-	-	0.1260	-	



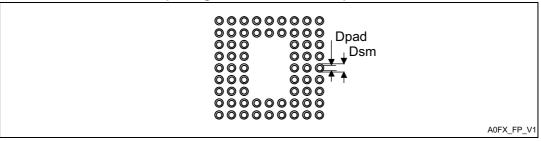
## Table 88. WLCSP64+2 - 66-ball, 4.539 x 4.911 mm, 0.4 mm pitch wafer level chip scale package mechanical data (continued)

Symbol		millimeters		inches <sup>(1)</sup>			
Symbol	Min	Тур	Max	Min	Тур	Max	
F	-	0.220	-	-	0.0087	-	
G	-	0.386	-	-	0.0152	-	
ааа	-	-	0.100	-	-	0.0039	
bbb	-	-	0.100	-	-	0.0039	
CCC	-	-	0.100	-	-	0.0039	
ddd	-	-	0.050	-	-	0.0020	
eee	-	-	0.050	-	-	0.0020	

1. Values in inches are converted from mm and rounded to 4 decimal digits.

2. Dimension is measured at the maximum bump diameter parallel to primary datum Z.

## Figure 80. WLCSP64+2 - 66-ball, 4.539 x 4.911 mm, 0.4 mm pitch wafer level chip scale package recommended footprint



#### Table 89. WLCSP64 recommended PCB design rules (0.4 mm pitch)

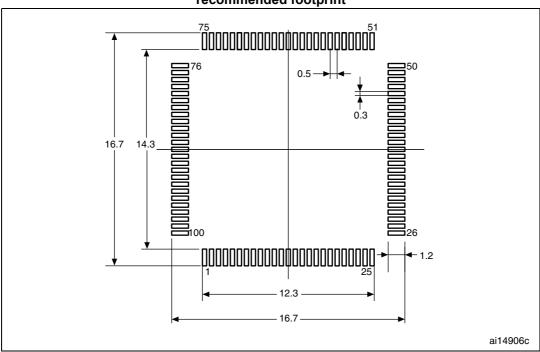
Dimension	Recommended values
Pitch	0.4
Dpad	0.225 mm
Dsm	0.290 mm typ. (depends on the soldermask registration tolerance)
Stencil opening	0.250 mm
Stencil thickness	0.100 mm

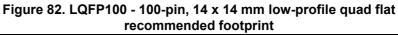


O maked		millimeters		inches <sup>(1)</sup>			
Symbol	Min	Тур	Мах	Min	Тур	Max	
D3	-	12.000	-	-	0.4724	-	
Е	15.800	16.000	16.200	0.6220	0.6299	0.6378	
E1	13.800	14.000	14.200	0.5433	0.5512	0.5591	
E3	-	12.000	-	-	0.4724	-	
е	-	0.500	-	-	0.0197	-	
L	0.450	0.600	0.750	0.0177	0.0236	0.0295	
L1	-	1.000	-	-	0.0394	-	
k	0.0°	3.5°	7.0°	0.0°	3.5°	7.0°	
CCC	-	-	0.080	-	-	0.0031	

## Table 90. LQPF100 - 100-pin, 14 x 14 mm low-profile quad flat packagemechanical data (continued)

1. Values in inches are converted from mm and rounded to 4 decimal digits.





1. Dimensions are expressed in millimeters.





#### **Device marking**

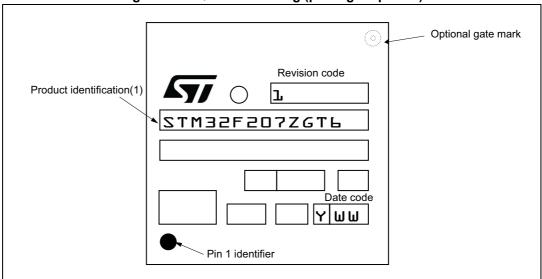


Figure 86. LQFP144 marking (package top view)

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